Certificate of Test

October 2004

CHROMA ATE INC

Product Type	: 4U Form Factor PXI 18-Slots Chassis
Model Number	: 52105
Test Report Number	: GTK-0410034
Date of Test	: October 13, 2004 – October 19, 2004

This Product was tested to the following standards at the laboratory of Global EMC Standard Tech. Corp., and found Compliance.

This report was modified as revision 2, which modified the model number for the requirement of marketing.

Standards: EN 55022 :1998 , CISPR 22, Class A EN 55024 :1998 IEC 61000-4 Series EN 61000-3-2 / 2000 & EN 61000-3-3 / 1995 + A1 / 2001

http://www.gestek.com.tw

Sharon Chang, President

Date: October 21, 2004

GesTek EMC Lab

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Declaration of Conformity

We, Manufacturer/Importer (full address)

declare that the product (description of the apparatus, system, installation to which it refers)

EUT: 4U Form Factor PXI 18-Slots Chassis

Model Number: 52105

is in conformity with

(reference to the specification under which conformity is declared)

in accordance with 89/336 EEC-EMC Directive

🗌 EN 55011	Limits and methods of measurement	🛛 EN 61000-3-2	Disturbances in supply systems caused
	industrial, scientific and medical (ISM) high frequency equipment	🛛 EN 61000-3-3	Disturbances in supply systems caused by household appliances and similar electrical equipment "Voltage fluctuations"
☐ EN 55013	Limits and methods of measurement Information Technology of radio disturbance characteristics of broadcast receivers and associated equipment	⊠ EN 55024	Information Technology equipment-Immunity characteristics-Limits and methods of measurement
☐ EN 55014-1	Limits and methods of measurement of radio disturbance characteristics of household electrical appliances, portable tools and similar electrical	☐ EN 61000-6-1	Generic standards-Immunity for residential, commercial and light-industrial environments
	apparatus	🗌 EN 61000-6-2	Generic standards-Immunity for industrial environments
EN 61000-6-3	Generic standards-Emission standard for residential, commercial and light-industrial environments	🗌 EN 55014-2	Immunity requirements for household appliances tools and similar apparatus
EN 61000-6-4	Generic standards-Emission standard for industrial environments	🗌 EN 50091-2	EMC requirements for uninterruptible power systems (UPS)
🗌 EN 55015	Limits and methods of measurement of radio disturbance characteristics of fluorescent lamps and luminaries	🗌 EN 55020	Immunity from radio interference of broadcast receivers and associated equipment
⊠ EN 55022	Limits and methods of measurement of radio disturbance characteristics of information technology equipment	🔲 EN 61204-3	Low voltage power supplies, d.c. output - Part 3: Electromagnetic compatibility. (EMC)
 DIN VDE 0855 part 10 part 12 	Cabled distribution systems; Equipment for receiving and/or distribution from sound and television signals	~	
🛛 CE marking		(EC conformity	r marking)
	The manufacturer also declares the c with the actual required safety standa	onformity of above me ards in accordance with	ntioned product h LVD 73/23 EEC
🗌 EN 60065	Safety requirements for mains operated electronic and related apparatus for household and similar general use	🔲 EN 60950	Safety for information technology equipment including electrical business equipment
🗌 EN 60335	Safety of household and similar electrical appliances	🔲 EN 50091-1	General and Safety requirements for uninterruptible power systems (UPS)
	Manufact	urer/Importer	
		Się	gnature:

Name:

European Union [EU] EMC Directive [89/336/EEC, As Amended]

EMC Test Report For:

CHROMA ATE INC

EUT: 4U Form Factor PXI 18-Slots Chassis

Model Number: 52105

Prepared for: CHROM ATE INC 43 Wu-Chuan Rd., Wu-Ku Ind. Park, Wu-Ku, Taipei Hsien 248, Taiwan, R.O.C.

> Report By : Global EMC Standard Tech. Corp. No.3 Pau-Tou-Tsuo Valley, Chia-Pau Tsuen, Lin Kou Hsiang, Taipei County, Taiwan, R.O.C. Tel : (02) 2603-5321 Fax : (02) 2603-5325

Test results given in this report only relate to the specimen(s) tested, measured.

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1. CERTIFICATION

Applicant

: CHROMA ATE INC

EUT Description	: 4U Form Factor PXI 18-Slots Chassis
Model Number	: 52105
Serial Number	: N/A
Tested Power Supply	: 230Vac/50Hz

MEASUREMENT PROCEDURES USED :

EN 55022 / 1998 AND EN 61000-3-2 / 2000 & EN 61000-3-3 / 1995 + A1 / 2001

EN 55024 / 1998 AND IEC 61000-4 SERIES REGULATIONS

For EN 55022 / 1998:

The measurements shown in the attachment were made in accordance with the procedures indicated, and the maximum emissions from the equipment were found to be within the applicable EN 55022 / 1998 limits.

For EN 55024 / 1998:

The measurement results are contained in this test report and show that the EUT to be technically compliant with the EN 55024 / 1998 Immunity regulations.

GENERAL REMARKS:

- The tests were performed according to the technical requirement of EUT.
 - Electro-magnetic Radiated Emission Interference Measurement (CISPR 22 / EN 55022)
 - Electro-magnetic Conducted Emission Interference Measurement (CISPR 22 / EN 55022)
 - Powerline Harmonic Current Emissions (EN 61000-3-2)
 - Fluctuation/Flicker Measurement (EN 61000-3-3)
- ☐ Floctation/Floct Nickasternicit (EN 61000-4-2)
 ☐ ESD Immunity Test (IEC 61000-4-2 / EN 61000-4-2)
 ☐ RF Field strength Susceptibility Test (IEC 61000-4-3 / EN 61000-4-3)
 ☐ Electrical Fast Transient/Burst Immunity Test (IEC 61000-4-4 / EN 61000-4-4)
 ☐ Surge Immunity Test (IEC 61000-4-5 / EN 61000-4-5)

- Conducted disturbance Susceptibility Test (IEC 61000-4-6 / EN 61000-4-6)
 Low Frequency Signals Immunity Test (IEC 1000-2-2)
 Power Frequency Magnetic Field Immunity Test (IEC 61000-4-8 / EN 61000-4-8)
 Voltage Dips/Short Interruptions Test (IEC 61000-4-11 / EN 61000-4-11)

Sample Received Date **Final Test Date**

: October 13, 2004 October 19, 2004

In order to ensure the quality and accuracy of this document, the contents have been thoroughly reviewed by the following qualified personnel from GesTek Lab.

Documented By :

INT

Rini Chen / adm. Dept. Supervisor

Technical Review By:

Paul Huang / eng. Dept. Engineer

Administrative Review By:

Rini Chen / adm. Dept. Supervisor

Approved By :

Tony Tsai / eng. Dept. Manager

2. SUMMARY OF TEST RESULTS

STANDARD	TEST ITEM	TEST RESULT	REMARKS
EN 55022 CISPR 22 Class A Canadian ICES-003 Class A	Conducted emission (Mode 1)	PASS	The worst emission frequency is <u>0.1984</u> MHz. And minimum passing margin is <u>-4.93</u> dB.
	Radiated emission (Mode 1)	PASS	The worst emission frequency is <u>219.9999</u> MHz at <u>Vertical.</u> And minimum passing margin is <u>-2.07</u> dB. Height of antenna is <u>4.0</u> M. Angle of turntable is <u>38°</u> .
EN 61000-3-2 / 2000 EN 61000-3-3 / 1995	Powerline Harmonic Current Emissions	PASS	With regards to the EN 61000-3-2, the PC must be tested at full load in order to reach the assigned current
+ A1 / 2001	Voltage Fluctuation and Flicker	PASS	of the Power supply. With Dummy Load Active Power > 75W
EN 55024 / 1998 IEC 61000-4-2	Electrostatic Discharge(ESD)	PASS	Contact discharge up to <u>±4kV</u> . Air discharge up to <u>±8kV</u> .
EN 55024 / 1998 IEC 61000-4-3	RF field strength Susceptibility	PASS	80-1000MHz (AM 80% @ 1KHz): 3V/m 80, 120, 160, 230, 434, 460, 600, 863 and 900MHz: 3V/m
EN 55024 / 1998 IEC 61000-4-4	Electrical Fast Transients/Burst	PASS	±0.5kV, ±1kV(AC Input) ±0.5kV(LAN)
EN 55024 / 1998 IEC 61000-4-5	Surge	PASS	±0.5kV, ±1kV, ±2kV(AC Input)
EN 55024 / 1998 IEC 61000-4-6	Conducted Disturbance Susceptibility	PASS	0.15-80MHz (AM 80% @ 1KHz): 3V(rms) 0.2, 1, 7.1, 13.56, 21, 27.12 and 40.68MHz: 3V(rms)
EN 55024 / 1998 IEC 61000-4-8	Power Frequency Magnetic Field	PASS	1A(rms)/m at 50Hz
EN 55024 / 1998	Voltage short Interruptions	PASS	>95% reduction, 5s
IEC 61000-4-11	Voltage Dips	FA00	>95% reduction, 10 ms 30% reduction, 500 ms

3. GENERAL INFORMATION

3.1 PRODUCT DESCRIPTION

Product Name	: 4U Form Factor PXI 18-Slots Chassis
Model Number	: 52105
Serial Number	: N/A
Applicant	: CHROMA ATE INC
Address	: 43 Wu-Chuan Rd., Wu-Ku Ind. Park, Wu-Ku, Taipei Hsien 248, Taiwan, R.O.C.
Manufacture	: CHROMA ATE INC
Address	: 66 Hwa-Ya 1Rd., Hwa-Ya Technical Park, Kuei-Shan Hsiang, Taoyuan Hsien, Taiwan. R.O.C.
Power Supply	: Voltage from PC's S.P.S. Input: 100-240V, 50-60Hz, 5A MAX

3.2 TEST MODES & EUT COMPONENTS DESCRIPTION

Test Mode	Mode 1
Model Number	CHROMA ATE INC. M/N: 52105

Note:

- 1. According to pre-scan data, we determine the data shown in this test report, which reflects the worst-case data for each operation mode.
- 2. This report was modified as revision 2, which modified the model number for the requirement of marketing.

3.3 CONFIGURATION OF THE SYSTEM UNDER TEST

The FCC IDs/Types for all equipment, plus descriptions of all cables used in the tested system (including inserted cards, which have grants) are:

Device	No.		Configuration
		Manufacturer	: ADI
		Model Number	: MICRO SCAN G1000
		Serial Number	: N/A
D-Sub Monitor	M01-029	BSMI ID	: 3892A351
		FCC ID	: N/A
		Data Cable	: Shielded, detachable, 1.5m, VGA Cable
		Power Cord	: 3Pin, Shielded, Detachable, 1.5m
		Manufacturer	: ACEEX
		Model Number	: 1414V
		Serial Number	: 0046177
		BSMI ID	: N/A
Modem	M03-023	FCC ID	: IFAXDM1414
		Data Cable	: T Type:RS232, Shielded, Detachable, 1.2m
		Power Cord	: Non-Shielded, Detachable, 1.5m
		Line	: Type:RJ11(4P2C), Detachable, 1.8m
		Phone	: Type:RJ11(4P2C). Detachable, 1.8m
		Manufacturer	: Hewlett Packard
		Model Number	: 2225C
		Serial Number	: 2512S40942
Printer	P01-015	BSMI ID	: 3892A957
	101-013	FCC ID	: BS46XU2225C
		Data Cable	Shielded Detachable 12m Parallel Cable
		Power Cord	Non-Shielded Detachable 1.8m
		Manufacturer	· Chroma
PC System		Model Number	: PXI 52941
PXI 52642		Manufacturer	: Chroma
Relay Card		Model Number	: PXI 52642
		Manufacturer	· TERASYS
		Model Number	· F12-LIF
		Serial Number	· A0100215-34P0017
		BSMLID	· 49124002
External USB 2.0	U02-023	Data Cable	: Shielded detachable 1.5m
Hard Disk		AC Power Adaptor	· VHL M/N·VS-1015-1120 BSMI ID://8720185
			Input: AC IN: 1001/ 50/60Hz 251/A
			$P_{1} = P_{1} = P_{1$
			Output. DC $+12^{\circ}$, 1.25A
		Manufacturer	: TERASYS
		Model Number	: F12-UF
		Serial Number	: A0100215-39H008
External USB 2.0		BSMI ID	: 4912A002
Hard Diek	U02-024	Data Cable	: Shielded, detachable, 1.5m
		AC Power Adaptor	: YHI, M/N:YS-1015-U12A, BSMI ID:4872A185
			Input:AC IN:100V, 50/60Hz, 35VA
			Output: DC +12V, 1.25A
		1	

Device	No.	Configuration		
HUB x 2		Manufacturer	: D-Link	
		Model Number	: DES-1008D (10/100BASE-T Ethernet Hub)	
		Data Cable to EUT	:Type:RJ45(UTP/8P8C), Detachable, 12 m, Twisted Pairs	
		Power Cord	: Non-Shielded, Detachable, 1.5m	
		Mother Board	: ASUS, M/N: TUSL2-C	
		F.D.D.	: Panasonic, M/N: JU-257A606P	
		H.D.D.	: Seagate, M/N: ST330621A	
		CD-ROM	: MITSUMI, M/N: CRMC-FX4830T	
For Frid Notwork		VGA Card	: On Board	
Far End Network		Sound	: On Board	
Server X Z		LAN	: On Board	
		SDRAM	: 32MB PC100	
		CPU	: Intel,733M/133MHz	
		S. P. S.	: DELTA, M/N: DTPS-200PB-109C	
		Power Cord	: Non-Shielded, Detachable, 1.8m	
	K01-033	Manufacturer	: TATUNG	
		Model Number	: KB-5923	
		Serial Number	: 8060032215	
PS2 Keyboard		BSMI ID	: 3862A177	
		FCC ID	: E8HKB-5923	
		Data Cable	: Shielded, Undetachable, 2 m	
		Purchase Date	: 8/6/1998	
		Manufacturer	: Logitech	
		Model Number	: M-S48A	
DC2 Maura	M02 446	Serial Number	: HCA11803174	
roz wouse	MU2-116	BSMI ID	: 4882A001	
		FCC ID	: JNZ201213	
		Data Cable	: Shielded, Undetachable, 1.5m	

3.4 TEST FACILITY

Items	Required (IEC 68-1)	Actual
Temperature (°C)	15-35	25-29
Humidity (%RH)	25-75 (45-75 for ESD, 1 st , ed.) (30-60 for ESD, 2 nd . ed)	50-60 for ESD 52-63 for others
Barometric pressure (mbar)	860-1060	950-1000

Site Description	: December 31, 2005 File on NEMKO EMC Laboratory Authorization
	Gaustadalleen 30, Postbox 73 Blindern, 0314 Oslo, Aut. No.: ELA 126
	Aug. 15, 1997 Recognition on Det Norske Veritas AS
	Statement No:510-96-1017
	Accreditation on NVLAP effective through September 30, 2005.
	For CISPR 22, FCC Method and AS/NZS 3548 Measurement.
	NVLAP Lab Code: 200085-0
	Registration on VCCI effective through June 28, 2007.
	Registration No.: R-291 and C-305
	Recognized by the Council of Chinese National Laboratory Accreditation
	As an accredited laboratory and registration No.:1082.
	Registration on CNLA effective through April 30, 2006.
Name of firm	: Global EMC Standard Tech. Corp.
Site location	: No. 3 Pau-Tou-Tsuo Valley, Chia-Pau Tsuen, Lin Kou Hsiang,
	Taipei County, Taiwan, R.O.C.



4. CONDUCTED EMISSION MEASUREMENT

4.1 TEST EQUIPMENTS

Item	Instrument	Manufacturer	Model	Serial No.	Last Cal. Date
1	Test Receiver	R & S	ESCS30	825022/003	06/26/04
2	L.I.S.N.(EUT)	KYORISTU	KNW-407	8-1345-10	11/20/03
3	L.I.S.N.(AE)	ROLF HEINE	NNB-2/16Z	98091	12/08/03
4	Pulse Limiter	R & S	ESH3-Z2	357.8810.52	08/06/04
5	RF CABLE	GTK	N/A	GTK-E-A154-01	12/02/03
6	50 Ohm Terminator	GTK	N/A	GTK-E-A130-01	10/09/04
7	Shielded Room	GTK	N/A	B5	N/A

Note: All equipment upon which need to calibrated are with calibration period of 1 year.

4.2 TEST METHOD

According to EN 55022 / 1998.

4.3 BLOCK DIAGRAM OF TEST SETUP

4.3.1 TEST SETUP FOR EMISSION MEASUREMENT AT MAINS TERMINAL



Note: This is a reprehensive setup diagram for Table-top EUT.

For Floor-standing EUT, the table will be removed with all others setup condition remain the same.

4.4 CONDUCTED EMISSION LIMITS

_	Maximum RF Line Voltage dB(uV)				
Frequency	Clas	ss A	Class B		
MHz	QUASI-PEAK AVERAGE		QUASI-PEAK	AVERAGE	
0.15 to 0.50	79	66	66 to 56	56 to 46	
0.50 to 5.0	73	60	56	46	
5.0 to 30	73	60	60	50	

Remarks: In the Above Table, the tighter limit applies at the band edges.

4.5 EUT CONFIGURATION ON MEASUREMENT

The equipments, which are listed at 4.3, are installed on Conducted Emission Test to meet the Commission requirement and operating in a manner which tends to maximize its emission characteristics in a normal application.

The device under test, installed in a representative system as described in section 4.3, was placed on a non-conductive table whose total height equaled 80 cm. The EUT was powered through one L.I.S.N. whose the signal output was terminated to the receiver. The other peripherals were powered from another L.I.S.N. whose the signal output was terminated by 50 Ohms terminator.

4.6 CONDUCTED EMISSION DATA

The measurement range of conducted emission, which is from <u>0.15 MHz to 30 MHz</u>, was investigated. The initial step in collecting conducted data is a spectrum analyzer peak scan of the measurement range for all the test modes. Then the worst modes were reported the following data pages.

The final measurement equal to Receiver reading plus a Correction factor when AMN insertion loss bigger than 0.5dB, the receiver added the correction factor to the reading level automatically.

4.7 OPERATING CONDITIONS OF THE EUT

The exercise program used during conducted emission measurement was designed to exercise the EUT in a manner similar to a typical use. The exercise sequence is listed as below:

- 1. Setup the EUT and simulators as shown on 4.3.
- 2. Turn on the power of all equipments.
- 3. Boot the P.C. from Hard Disk and setup the video to windows XP OS, active all devices.
- 4. Adjust to appropriate video resolution.
- 5. Running "PXI 52642 Relay Card" test program.
- 6. P.C. sent "H" pattern to monitor, make the "H" pattern full in the screen.
- 7. P.C. sent "H" pattern to parallel and serial port.
- 8. Repeat above steps.

4.8 CONDUCTED EMISSION MEASUREMENT RESULTS

Date of Test	October 18, 2004	Temperature	25
EUT	4U Form Factor PXI 18-Slots Chassis	Humidity	63 %
Test Mode	Mode 1	Display Pattern	H Pattern

Line

No	Frequency MHz	Reading Level dBµV	Factor dB	Measurement dBµV	Limit dBµV	Over Limit dB	Detector	
1	0.1984	54.4	10.21	64.61	79	-14.39	QP	
2	0.1984	50.86	10.21	61.07	66	-4.93	AVG	
3	0.2972	39.17	10.15	49.32	79	-29.68	QP	
4	0.2972	34.56	10.15	44.71	66	-21.29	AVG	
5	0.3971	39.47	10.1	49.57	79	-29.43	QP	
6	0.3971	34.99	10.1	45.09	66	-20.91	AVG	
7	0.4218	39.54	10.1	49.64	79	-29.36	QP	
8	0.4218	36.49	10.1	46.59	66	-19.41	AVG	
9	0.7001	34.72	10.1	44.82	73	-28.18	QP	
10	0.7001	31.69	10.1	41.79	60	-18.21	AVG	
11	8.7253	26.71	10.26	36.97	73	-36.03	QP	
12	8.7253	23.15	10.26	33.41	60	-26.59	AVG	

Remarks :

1 All readings are Quasi-peak and Average values.

2 " " means that this data is the worse case emission level.

3 Final measurement = (Receiver reading) + (Factor if available).



Date of Test	October 18, 2004	Temperature	25
EUT	4U Form Factor PXI 18-Slots Chassis	Humidity	63 %
Test Mode	Mode 1	Display Pattern	H Pattern

Neutral

No	Frequency MHz	Reading Level dBµV	Factor dB	Measurement dBµV	Limit dBµV	Over Limit dB	Detector
1	0.2033	50.93	10.2	61.13	79	-17.87	QP
2	0.2033	47.53	10.2	57.73	66	-8.27	AVG
3	0.2963	39.17	10.15	49.32	79	-29.68	QP
4	0.2963	34.65	10.15	44.8	66	-21.2	AVG
5	0.3992	41.01	10.1	51.11	79	-27.89	QP
6	0.3992	36.44	10.1	46.54	66	-19.46	AVG
7	0.5268	37.28	10.1	47.38	73	-25.62	QP
8	0.5268	34.66	10.1	44.76	60	-15.24	AVG
9	0.7368	34.68	10.1	44.78	73	-28.22	QP
10	0.7368	32.8	10.1	42.9	60	-17.1	AVG
11	8.7246	26.33	10.26	36.59	73	-36.41	QP
12	8.7246	22.54	10.26	32.8	60	-27.2	AVG

Remarks :

1 All readings are Quasi-peak and Average values.

2 " means that this data is the worse case emission level.

3 Final measurement = (Receiver reading) + (Factor if available).



Neutral

5. RADIATED EMISSION MEASUREMENT

5.1 TEST EQUIPMENT

The following test equipments are used during the radiated emission tests:

Radiated emission measurement was performed at: Site #1 Site #2 Site #3 Site #4

Item	Instrument	Manufacturer	Model	Serial No.	Last Cal. Date
1	Test Receiver	R & S	ESCS30	825022/003	06/26/04
2	Spectrum Analyzer	HP	8542E	3520A00123/ 3427A00118	07/21/04
3	Pre-Amplifier	HP	8447F OPT H64	3113A04487	110/09/04
4	BILOG Antenna	Chase	CBL6112B	2580	12/01/03
5	RF Cable	GTK-E-A150-01	N/A	12/22/03	12/22/03
6	Open Site	GesTek	B2	N/A	N/A

Note: All equipment upon which need to calibrated are with calibration period of 1 year.

5.2 TEST METHOD

According to EN 55022 / 1998.

Radiated emission measurement was performed at the antenna to EUT distance of 10 meters.

5.3 BLOCK DIAGRAM OF TEST SETUP

5.3.1 BLOCK DIAGRAM OF CONNECTIONS BETWEEN EUT AND SIMULATORS

Note: This is a reprehensive setup diagram for Table-top EUT. For Floor-standing EUT, the table will be removed with all others setup condition remain the same.



5.3.2 OPEN AREA TEST SITE & ANECHOIC CHAMBER SETUP DIAGRAM

Note: This is a reprehensive setup diagram for Table-top EUT. For Floor-standing EUT, the table will be removed with all others setup condition remain the same.



5.4 RADIATED EMISSION LIMITS

Frequency	Distance	Field Strength				
MHz	Meter	dB(uV/m)				
30 to 230	10	30				
230 to 1000	10	37				
Class A Limits						
Frequency	Distance	Field Strength				
MHz	Meter	dB(uV/m)				
30 to 230	10	40				
230 to 1000	10	47				

Remark: 1. The tighter limit shall apply at the edge between two frequency bands.

2. Distance refers to the distance in meters between the measuring antenna and the closest point of any part of the device or system.

5.5 EUT CONFIGURATION

The EUT, which is listed at 5.3.1., was installed at the Radiated Emission Test site to meet the Commission requirements and operated in a manner, which tends to maximize its emission characteristics in a normal application.

The EUT, installed in a representative system as described in section 5.3.2, was placed on a non-conductive table whose total height equaled 80 cm. This table can be rotated 360 degrees. The measurement antenna was mounted to a non-conductive mast capable of moving the antenna vertically. Antenna height was varied from 1 meter to 4 meters and the system under test was rotated from 0 degree through 360 degrees relative to the antenna position and polarization (Horizontal and Vertical). Also the I/O cable positions were investigated to find the maximum emission condition.

5.6 OPERATING CONDITIONS OF THE EUT

Same as conducted emission measurement, which is listed in 4.7

5.7 RADIATED EMISSION DATA

The frequency range of radiated emissions from <u>30 MHz to 1 GHz</u> was investigated. The initial step in collecting emission data was a spectrum analyzer peak scan of the frequency range for all the test modes. Then the worst modes were reported the following data pages.

Date of Test	October 13, 2004	Temperature	26 deg/C
EUT	4U Form Factor PXI 18-Slots Chassis	Humidity	59 %RH
Working Cond.	Mode 1	Display Pattern	H Pattern
Antenna distance	10m at Horizontal	Frequency Range	30-1000MHz

5.8 RADIATED EMISSIONS MEASUREMENT RESULTS

No.	Frequency MHz	Reading Level dBuV/m	Factor dB	Measurement dBuV/m	Limit dBuV/m	Over Limit dB	Detector
1	165.9123	49.64	-15.44	34.2	40	-5.8	QP
2	186.1631	44.41	-15.81	28.6	40	-11.4	QP
3	198.79	46	-15.84	30.16	40	-9.84	QP
4	214.77	41.72	-14.27	27.45	40	-12.55	QP
5	239.99	41.7	-12.77	28.93	47	-18.07	QP
6	239.9983	41.09	-12.77	28.32	47	-18.68	QP
7	265.36	38.1	-11.55	26.55	47	-20.45	QP
8	286.3619	41.69	-10.67	31.02	47	-15.98	QP
9	298.3431	33.32	-10.34	22.98	47	-24.02	QP
10	326.133	43.76	-9.44	34.32	47	-12.68	QP
11	331.7754	32.21	-9.4	22.81	47	-24.19	QP
12	358	36.4	-8.53	27.87	47	-19.13	QP
13	398.1926	42.05	-7.83	34.22	47	-12.78	QP
14	497.74	32.67	-6.21	26.46	47	-20.54	QP
15	597.2388	42.9	-4.23	38.67	47	-8.33	QP
16	696.385	33.95	-2.53	31.42	47	-15.58	QP
17	729.9198	29.68	-1.89	27.79	47	-19.21	QP
18	768.12	28.22	-1.48	26.74	47	-20.26	QP
19	796.4335	30.58	-0.94	29.64	47	-17.36	QP
20	898.1958	33.54	1.11	34.65	47	-12.35	QP

Remarks:

1. All Readings below 1GHz are Quasi-Peak.

2. Emission Level= Reading + Factor (Could have ±0.01 tolerance due to computer automatically round off calculation).

3. Over Limit (Margin Value)=Measurement level-Limit value.

4. The " " means this data is worst-case Measurement level.

Date of Test	October 13, 2004	Temperature	26 deg/C
EUT	4U Form Factor PXI 18-Slots Chassis	Humidity	59 %RH
Working Cond.	Mode 1	Display Pattern	H Pattern
Antenna distance	10m at Vertical	Frequency Range	30-1000MHz

No	Frequency	Reading Level	Factor	Measurement	Limit	Over Limit	Detector
NO.	MHz	dBuV/m	dB	dBuV/m	dBuV/m	dB	Delector
1	165.9628	44.19	-15.44	28.75	40	-11.25	QP
2	199.2495	46.12	-15.87	30.25	40	-9.75	QP
3	219.9999	51.79	-13.86	37.93	40	-2.07	QP
4	232.2807	33.17	-13.21	19.96	47	-27.04	QP
5	239.9996	41.79	-12.77	29.02	47	-17.98	QP
6	257.7232	37.32	-11.82	25.5	47	-21.5	QP
7	265.2604	36.95	-11.56	25.39	47	-21.61	QP
8	299.999	46.04	-10.22	35.82	47	-11.18	QP
9	314.9965	41.16	-9.73	31.43	47	-15.57	QP
10	339.999	35.42	-9.12	26.3	47	-20.7	QP
11	398.3441	38.03	-7.83	30.2	47	-16.8	QP
12	597.4405	33.43	-4.22	29.21	47	-17.79	QP
13	696.8857	30.1	-2.52	27.58	47	-19.42	QP
14	796.4351	32.41	-0.94	31.47	47	-15.53	QP

Remarks:

1. All Readings below 1GHz are Quasi-Peak.

2. Emission Level= Reading + Factor (Could have ±0.01 tolerance due to computer automatically round off calculation).

3. Over Limit (Margin Value)=Measurement level-Limit value.

4. The " " means this data is worst-case Measurement level.

Horizontal

80.0 dBu∀/m Limit: Margin: 40 20 10 × 13 X 16 3³ 19 12 17 18 14 X 3 X 11 0.0 30.000 1000.000 MHz 515.000 Vertical 80.0 dBuV/m Limit: Margin: 40 8 9 X 14 X 11 5 X 12 13 10 67 XX 0.0

515.000

30.000

1000.000

MHz

6. POWERLINE HARMONIC CURRENT EMISSIONS AND VOLTAGE FLUCTUATION/FLICKER MEASUREMENT

6.1 TEST EQUIPMENT

ltem	Instrument	Manufacturer	Model	Serial No.	Last Cal. Date
1	Power Analyzer	Voltech	PM3000A	AH07/9016	08/02/04
2	Power Source	PACIFIC	345AMX/UPC32	270	12/18/03
3	Impedance Network	Voltech	IEC STANDARD 555	IB0718921	08/04/04
4	Test Program	GesTek	GTK-E-S002-01	N/A	N/A

Note: All measurement critical items of test instrumentation were within their calibration period of 1 year.

6.2 TEST METHOD

According to EN 61000-3-2 / 2000 & EN 61000-3-3 / 1995 + A1 / 2001.

6.3 BLOCK DIAGRAM OF TEST SETUP

Note: This is a reprehensive setup diagram for Table-top EUT. For Floor-standing EUT, the table will be removed with all others setup condition remain the same.



6.4 LIMITS OF HARMONIC CURRENT EMISSIONS

\boxtimes	Class D

Harmonics Order	Maximum Permissible Harmonic current Per watt (mA/W)	Maximum Permissible Harmonic current A
3	3.4	2.30
5	1.9	1.14
7	1.0	0.77
9	0.5	0.40
11	0.35	0.33
$13 \le n \le 39$	3.85	See table 1
(Odd harmonics only)		

Note: Harmonic currents less than 0.6% of the input current measured under the

test conditions, or less than 5mA, whichever is greater, are disregarded.

6.5 OPERATING CONDITIONS OF THE EUT

- 1. Setup the EUT and Test Equipment as shown on 6.3.
- 2. Power on the EUT. Acting performance checking program to allow EUT executing its usual operation mode during test.

6.6 TEST PROCEDURE

Power Line Harmonics:

The EUT was supplied in series with power analyzer from a power source having the same nominal voltage and frequency as the rated supply voltage of the equipment under test. The supply voltage of the EUT was varied over the voltage range of 0.94 times to 1.06 times the nominal voltage to produce worst-case emission.

6.7 TEST RESULT

- 1. The measurement of the power harmonics, which test at the extremes of EUT's supply range was investigated, and the test result are reported the following data pages. The measurement limits were met, and the EUT **passed** the test.
- 2. The EUT was complying to limit of Class D.

		Curren	t Test Result	Summary (Run	time)		
EUT: 4U	EUT: 4U Form Factor PXI 18-Slots Chassis Tested by: Paul						
Test date	9019: Class	-D per A-14 (Eur	Start time: A) M 11.19.16	Find t	imargin: 100	10.56
Tost dur	tion (min):	1	Data filo nan	10111.10.40	Liiu i data	IIIIe. AWI II.	19.50
Common	$\frac{1}{1000} (1000).$	1	Data me nam	пе. п-000404.cts	_uala		
Commen							
Custome	r: FULL Sta						
Test Res	ult: Pass	Source qualific	ation: Norr	nal			
THC(A):	0.05 I	-THD(pk%): 10.8	8 P	OHC(A): 0.007	POHC	: Limit(A): 0.0)37
Highest p	parameter va	alues during tes	t:	_		_	
	V_RMS (\	/olts): 228.41		Fre	equency(Hz):	50.00	
	I_Peak (A	mps): 0.988		I_F	MS (Amps):	0.477	
	I_Fund (A	(mps): 0.472		Cre	est Factor: 2	122	
11	Power (w				wer Factor: (J.791	O 1-1
Harm#	Harms(avg	3) 100%Limit	%of Limit	Harms(max)	150%LIMIt	%of Limit	Status
2	0.000	0.202	0.6	0.020	0.420	C 00	Deee
ວ ⊿	0.020	0.292	9.0	0.030	0.429	0.00	Pass
4	0.000	0 162	10.9	0.010	0 220	7 77	Dace
5	0.010	0.105	10.0	0.013	0.235	1.11	F 833
7	0.000	0.086	29.3	0.026	0 1 2 6	20.69	Pass
8	0.020	0.000	20.0	0.020	0.120	20.05	1 435
ğ	0.000	0 043	16 1	0.008	0 064	12 31	Pass
10	0.000	01010		01000	01001		1 400
11	0.009	0.030	29.9	0.010	0.045	21.52	Pass
12	0.000						
13	0.014	0.026	54.2	0.015	0.038	39.46	Pass
14	0.000						
15	0.006	0.022	28.4	0.007	0.032	20.68	Pass
16	0.000						
17	0.010	0.020	48.5	0.010	0.029	35.13	Pass
18	0.000						
19	0.004	0.017	23.4	0.004	0.026	17.16	Pass
20	0.000		. – –				_
21	0.002	0.016	15.5	0.003	0.023	11.60	Pass
22	0.000	0.044	40.4	0.000	0.004	40.00	Deee
23	0.003	0.014	18.4	0.003	0.021	13.69	Pass
24	0.000	0.012	20.2	0.004	0 0 2 0	20.70	Daca
25	0.004	0.015	20.5	0.004	0.020	20.79	F a 3 3
20	0.000	0 012	26.3	0 004	0 018	19 64	Pass
28	0.000	0.012	20.0	0.004	0.010	10.04	1 455
29	0.001	0.011	8.0	0.001	0.017	6.78	Pass
30	0.000					••	
31	0.002	0.011	15.5	0.002	0.016	11.48	Pass
32	0.000						
33	0.002	0.010	21.0	0.002	0.015	15.25	Pass
34	0.000						
35	0.001	0.009	13.4	0.002	0.014	10.83	Pass
36	0.000						_
37	0.001	0.009	11.3	0.001	0.013	8.85	Pass
38	0.000		<u> </u>	0.000	0.045	4 = 4 =	-
39	0.002	0.009	20.1	0.002	0.012	15.19	Pass
40	0.000						

Note: Dynamic limits were applied for this test. The highest harmonics values in the above table may not occur at the same window as the maximum harmonics/limit ratio.

Flicker Test Summary per EN/IEC61000-3-3 (Run time)

EUT: 4U Form Factor PXI 18-Slots ChassisTested by: PaulTest category: All parameters (European limits)Test Margin: 100Test date: 2004/10/18Start time: AM 11:24:48End time: AM 11:35:01Test duration (min): 10Data file name: F-000485.cts_dataComment: M/N: PXI-52105Customer: FULL SYSTEM

Test Result: Pass Status: Test Completed

Psti and limit line European Limits

Time is too short for Plt plot

Parameter values recorded during the test:

Vrms at the end of test (Volt): 228	8.19	
Highest dt (%):0.00	Test limit (%): 3.30	Pass
Time(mS) > dt: 0.0	Test limit (mS): 500.0	Pass
Highest dc (%):0.00	Test limit (%): 3.30	Pass
Highest dmax (%): 0.00	Test limit (%): 4.00	Pass
Highest Pst (10 min. period): 0.001	Test limit: 1.000	Pass
Highest Plt (2 hr. period): 0.001	Test limit: 0.650	Pass

7. ESD IMMUNITY TEST

7.1 TEST EQUIPMENT

Item	Instrument	Manufacturer	Model	Serial No.	Last Cal. Date
1	ESD SIMULATOR SYSTEM	HAEFELY	PESD 1600	H 107 335	12/15/03
2	Shielded Room	GesTek	B4	N/A	N/A

Note: All measurement critical items of test instrumentation were within their calibration period of 1 year.

7.2 TEST METHOD

According to EN 55024 :1998/ CISPR 24 :1997

IEC 61000-4-2/1995 (EN 61000-4-2/1995)

7.3 BLOCK DIAGRAM OF TEST SETUP

Note: This is a reprehensive setup diagram for Table-top EUT. For Floor-standing EUT, the table will be removed with all others setup condition remain the same.



7.4 SEVERITY LEVELS

Required Performance Criteria Level B
 ±8kV and lower levels (Air Discharge)
 ±4kV and lower levels (Contact Discharge)

7.5 OPERATING CONDITIONS OF THE EUT

- 1. Setup the EUT and Test Equipment as shown on 7.3.
- 2. Power on the EUT. Acting performance checking program to allow EUT executing its usual operation mode during test.

7.6 TEST PROCEDURE

Direct ESD :

Single discharge at > 1-second interval, at least 10 positive & 10 negative discharges. Air discharges to surfaces of the EUT.

Air Discharge:

This test was performed on non-conductive surfaces in accordance with EN 61000-4-2. Contact Discharge:

Single discharge at > 1-second interval, at least 25 positive & 25 negative discharges. Indirect ESD:

Horizontal Coupling Plane (HCP) under the EUT & Vertical Coupling Plane (VCP) beside the 4 sides of the EUT, with the sharp discharge electrode touching the coupling plane. HCP discharge:

ESD was applied to the earth reference plane on each accessible side of the EUT. VCP discharge:

Vertical Coupling Plane was positioned at a distance of 0.1m from the EUT.

7.7 TEST RESULT

Date of Test	October 19, 2004	Temperature	22.6
Test Mode	Mode 1	Humidity	66 %

ltem	Amount of Discharge	Voltage	Required Criteria	Complied to Criteria (A, B, C)	Result
Air Direct	10	⊠+2kV ⊠+4kV ⊠+8kV □+15kV	В	А	PASS
Discharge	10	⊠-2kV ⊠-4kV ⊠-8kV □-15kV	В	А	PASS
Contact	25	⊠+2kV ⊠+4kV □+6kV □+8kV	В	А	PASS
Discharge	25	⊠-2kV ⊠-4kV □-6kV □-8kV	В	А	PASS
Indirect Discharge	25	⊠+2kV ⊠+4kV □+6kV □+8kV	В	А	PASS
(HCP)	25	⊠-2kV ⊠-4kV □-6kV □-8kV	В	А	PASS
Indirect Discharge	25	⊠+2kV ⊠+4kV □+6kV □+8kV	В	А	PASS
(VCP) (Front)	25	⊠-2kV ⊠-4kV □-6kV □-8kV	В	A	PASS
Indirect Discharge	25	⊠+2kV ⊠+4kV □+6kV □+8kV	В	А	PASS
(VCP) (Left)	25	⊠-2kV ⊠-4kV □-6kV □-8kV	В	А	PASS
Indirect Discharge (VCP) (Back)	25	⊠+2kV ⊠+4kV □+6kV □+8kV	В	А	PASS
	25	⊠-2kV ⊠-4kV □-6kV □-8kV	В	А	PASS
Indirect Discharge	25	⊠+2kV ⊠+4kV □+6kV □ +8kV	В	A	PASS
(VCP) (Right)	25	⊠-2kV ⊠-4kV □-6kV □-8kV	В	А	PASS

Meet criteria A: Operate as intended during and after the test

- Meet criteria B: Operate as intended after the test
- Meet criteria C: Loss/Error of function
- Additional Information
 - □ There was no observable degradation in performance.
 - \boxtimes No false alarms or other malfunctions were observed during or after the test. The **The blue tag means the air discharge point**.

The rad tag means the contact point .

8. RF FIELD STRENGTH SUSCEPTIBILITY TEST

8.1 TEST EQUIPMENT

ltem	Instrument	Manufacturer	Model	Serial No.	Last Cal. Date
1	Signal Generator	MARCONI	2030	3110196	06/29/04
2	Power Amplifier	A & R	150W1000	304198	N/A
3	Field Strength Meter	A & R	FM2000	16837	N/A
4	BILOG Antenna	SCHAFFNER	CBL6111	1383	10/09/04
5	Shielded Room	GesTek	B3	N/A	12/04/03
6	EMI & EMS Program	CooTok	GTK-E-S001-01	NI/A	NI/A
0	Software GesTek		GTK-E-S004-01	IN/A	IN/A

Note: All measurement critical items of test instrumentation were within their calibration period of 1 year.

8.2 TEST METHOD

According to EN 55024 : 1998 / CISPR 24 : 1997

IEC 61000-4-3/1995+A1/1998+A2:2000 (EN 61000-4-3/1995+A1/1998+A2:2000).

8.3 BLOCK DIAGRAM OF TEST SETUP

Note: This is a reprehensive setup diagram for Table-top EUT. For Floor-standing EUT, the table will be removed with all others setup condition remain the same.



8.4 SEVERITY LEVELS

Required Performance Criteria : A Level : 80~1000MHz(AM 80/% @ 1KHz): 3V/m. According to EN 55024 / CISPR 24, an additional functional test shall be carried out at The following frequencies: 80, 120, 160, 230, 434, 460, 600, 863 and 900(+/- 1%)MHz.

8.5 OPERATING CONDITIONS OF THE EUT

1. Setup the EUT and Test Equipment as shown on 8.3.

2. Power on the EUT. Acting performance checking program to allow EUT executing its usual operation mode during test.

8.6 TEST PROCEDURE

The EUT and load were placed on a table, which was 0.8 meters high. The field sensor was also placed on the same table to monitor field strength from transmitting antenna. EUT was set 3 meters away from the transmitting antenna. The transmitting antenna was fixed at 1 meter above ground. Both horizontal and vertical polarizations of the antenna were used during testing. In order to judge the EUT performance, a CCD camera was used to monitor the EUT screen.

All the scanning conditions are as follows:

Condition of Test	Remarks
Field Strength	3V/m
Radiated Signal	80MHz-1000MHz (1KHz carrier wave with
_	80% Amplitude modulation)
Frequency step size Δf :	$\Delta f = f n - f (n-1) = \frac{1}{2} f (n-1)$
Where: Δ	f = frequency step size Q
f (n-1)	= previous test frequency
	f n = Next test frequency
	Q = Ratio center frequency to
bandwidth	

8.7 TEST RESULT

Date of Test	October 18, 2004	Temperature	22.9
Test Mode	Mode 1	Humidity	66 %

Freq. Range (MHz)	Position (Angle)	Polarity (H or V)	Field Strength (V/M)	Performance Criteria Complied to	Results
	0	H/V	3	А	PASS
⊠ 20-30 MHz	90	H/V	3	A	PASS
900 ± 5 MHz	180	H/V	3	A	PASS
	270	H/V	3	A	PASS

Additional comprehensive functional test selected frequencies are:

80.	120	160.	230	434	460	600	. 863	and	900	(+/- 1%)MHz.
2				,;	:		,		,		/

Freq. Range (MHz)	Position (Angle)	PolarityField StrengthPerformance Criteria(H or V)(V/m)Complied to		Results	
80	0;90;180;270	H/V	3	А	PASS
120	0;90;180;270	H/V	3	А	PASS
160	0;90;180;270	H/V	3	А	PASS
230	0;90;180;270	H/V	3	А	PASS
434	0;90;180;270	H/V	3	А	PASS
460	0;90;180;270	H/V	3	А	PASS
600	0;90;180;270	H/V	3	А	PASS
863	0;90;180;270	H/V	3	A	PASS
900	0;90;180;270	H/V	3	A	PASS

 \boxtimes Meet criteria A: Operate as intended during and after the test

Meet criteria B: Operate as intended after the test

Meet criteria C: Loss/Error of function

Additional Information

 \boxtimes There was no observable degradation in performance.

EUT stopped operation and <u>could</u> / <u>could not</u> be reset by operator at _____V/m at frequency__MHz.

☑ No false alarms or other malfunctions were observed during or after the test. The acceptance criteria were met, and the EUT passed the test.

9. ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST

9.1 TEST EQUIPMENT

ltem	Instrument	Manufacturer	Model	Serial No.	Last Cal. Date
1	ULTRA COMPACT	EM TEST	LICS 500-M	0500-15	07/10/04
	GENERATOR		000 300-10	0300-13	07/10/04

Note: All measurement critical items of test instrumentation were within their calibration period of 1 year.

9.2 TEST METHOD

According to EN 55024 : 1998 / CISPR 24 : 1997

IEC 61000-4-4/1995 (EN 61000-4-4/1995).

9.3 BLOCK DIAGRAM OF TEST SETUP

Note: This is a reprehensive setup diagram for Table-top EUT.

For Floor-standing EUT, the table will be removed with all others setup condition remain the same.



9.4 SEVERITY LEVELS

Required Performance Criteria Level : B : ±0.5kV for Signal Lines and Control Lines ±0.5kV, ±1.0kV for Power Lines and protective earth terminal

9.5 OPERATING CONDITIONS OF THE EUT

- 1. Setup the EUT and Test Equipment as shown on 9.3.
- 2. Power on the EUT. Acting performance checking program to allow EUT executing its usual operation mode during test.

The EUT and its load were placed on a table which was 0.8 meters above a metal ground plane measuring 2m by 2m and 0.65mm thick min, and projecting beyond the EUT by at least 0.1m on all sides. More then 0.5 meters separated the EUT from the walls of the shielded room.

Prior to the start of the test, a functional test was performed on the EUT to ensure proper operation. The EUT was also monitored during the test for any degradation of performance.

For AC Power lines test:

The EUT is connected to the power mains through a coupling/decoupling network that directly injected the transient energy. Bursts of pulse trains were injected onto the power line, in both positive and negative polarities. The test level was 0.5kV and 1.0kV The Line, Neutral, and protective earth conductors were impressed with burst noise for one minute.

For Signal Lines and Control Lines test:

The EFT interference signal was looped through a capacitive coupling clamp device to the signal and control lines of the EUT. The clamp meets the requirements of IEC 61000-4-4:1995. The clamp was placed on the ground plane, and the data lines were placed inside the clamp. Bursts of pulse trains were injected onto the data lines, in both positive and negative polarities. The test level was 0.5kV run for one minute for each polarity on each cable.

After completion of the test, a functional test was performed on the EUT to ensure proper operation.

9.6 TEST RESULT

Date of Test	October 18, 2004	Temperature	22.4
Test Mode	Mode 1	Humidity	68 %

Inject Plac	Inject Place: Power Supply Line										
Inject	Polarity	Voltage	Inject time	Inject	Required	Complied	Result				
Line	-	KV	(minute)	Method	Criteria	to Criteria					
L			1	DIRECT	В	A	PASS				
N			1	DIRECT	В	A	PASS				
PE		0.5	1	DIRECT	В	A	PASS				
L+N	+	🛛 1.0	1	DIRECT	В	А	PASS				
N+PE		2.0	1	DIRECT	В	А	PASS				
L+PE			1	DIRECT	В	А	PASS				
L+N+PE			1	DIRECT	В	А	PASS				
L			1	DIRECT	В	А	PASS				
N			1	DIRECT	В	А	PASS				
PE		0.5	1	DIRECT	В	А	PASS				
L+N	-	1.0	1	DIRECT	В	А	PASS				
N+PE		2.0	1	DIRECT	В	A	PASS				
L+PE			1	DIRECT	В	А	PASS				
L+N+PE			1	DIRECT	В	А	PASS				
Inject Plac	e: I/O Cal	ble (Capa	citive Clamp	Used)							
LAN	+	0.5	1	Clamp	В	А	PASS				
LAN	-	1.0	1	Clamp	В	А	PASS				

 $\boxtimes \operatorname{Meet}$ criteria A: Operate as intended during and after the test

Meet criteria B: Operate as intended after the test

☐ Meet criteria C: Loss/Error of function

⊠ Additional Information

- \boxtimes There was no observable degradation in performance.
- □ EUT stopped operation and <u>could</u> / <u>could not</u> be reset by operator at _____V/m at frequency__MHz.
- ☑ No false alarms or other malfunctions were observed during or after the test. The acceptance criteria were met, and the EUT passed the test.

10. SURGE IMMUNITY TEST

10.1 TEST EQUIPMENT

Item	Instrument	Manufacturer	Model	Serial No.	Last Cal. Date
1	ULTRA COMPACT GENERATOR	EM TEST	UCS 500-M	0500-15	07/10/04

Note: All equipment upon which need to calibrated are with calibration period of 1 year.

10.2 TEST METHOD

According to EN 55024:1998 / CISPR 24 : 1997

IEC 61000-4-5/1995 (EN 61000-4-5/1995).

10.3 BLOCK DIAGRAM OF TEST SETUP

Note: This is a reprehensive setup diagram for Table-top EUT.

For Floor-standing EUT, the table will be removed with all others setup condition remain the same.



10.4 SEVERITY LEVELS

Open Circuit Output Test Voltage +/- 10%						
Level	On power supply lines					
1	0.5KV					
2	1KV					
3	2KV					
4	4KV					
Х	Special					

10.5 OPERATING CONDITIONS OF THE EUT

1. Setup the EUT and Test Equipment as shown on 10.3.

2. Power on the EUT. Acting performance checking program to allow EUT executing its usual operation mode during test.

10.6 TEST PROCEDURE

A "combination wave" as specified in IEC 61000-4-5:1995 was applied to the EUT. The amplitude was gradually increased using control software. Surges were initiated line synced. One surge per polarity and voltage level was applied in common and differential mode to the EUT at 0, 90, 180, 270, and 0 degree phase angles. The surges were applied at a rate of 1 surge per minute. The EUT was monitored for any degradation of performance. The AC test was conducted for differential mode at 1.0kV and common mode at 2.0kV. All tests were run in both the positive and negative polarity for differential and common modes.

10.7 TEST RESULT

Date of Test	October 18, 2004	Temperature	22.7
Test Mode	Mode 1	Humidity	67 %

Inj	ject Line	Voltage KV	Repetition Rate (minute)	Phase Angle	Surge applied Method	Number of tests	Required Criteria	Complied to Criteria	Result
			1	0°	Coupling	5	В	А	PASS
		⊠+0.5	1	90°	Coupling	5	В	A	PASS
		⊠+1.0	1	180°	Coupling	5	В	A	PASS
I N	Differential		1	270°	Coupling	5	В	A	PASS
L-IN	mode		1	0°	Coupling	5	В	А	PASS
		⊠-0.5	1	90°	Coupling	5	В	A	PASS
		⊠-1.0	1	180°	Coupling	5	В	A	PASS
			1	270°	Coupling	5	В	A	PASS
			1	0°	Coupling	5	В	A	PASS
		⊠+0.5 ⊠+1.0 ⊠+2.0	1	90°	Coupling	5	В	A	PASS
			1	180°	Coupling	5	В	A	PASS
	Common		1	270°	Coupling	5	В	A	PASS
	mode		1	0°	Coupling	5	В	A	PASS
		⊠-0.5 ⊠-1.0	1	90°	Coupling	5	В	A	PASS
		⊠-1.0	1	180°	Coupling	5	В	A	PASS
			1	270°	Coupling	5	В	A	PASS
			1	0°	Coupling	5	В	A	PASS
			1	90°	Coupling	5	В	A	PASS
		\square +2.0	1	180°	Coupling	5	В	A	PASS
	Common		1	270°	Coupling	5	В	A	PASS
IN-I ∟	mode		1	0°	Coupling	5	В	A	PASS
		⊠-0.5 ⊠₋1.0	1	90°	Coupling	5	В	A	PASS
		⊠-1.0	1	180°	Coupling	5	В	А	PASS
		⊠-2.0	1	270°	Coupling	5	В	A	PASS

 \boxtimes Meet criteria A: Operate as intended during and after the test

Meet criteria B: Operate as intended after the test

Meet criteria C: Loss/Error of function

⊠ Additional Information

 $\boxtimes\,$ There was no observable degradation in performance.

EUT stopped operation and <u>could</u> / <u>could not</u> be reset by operator at _____V/m at frequency__MHz.

☑ No false alarms or other malfunctions were observed during or after the test. The acceptance criteria were met, and the EUT passed the test.

11. CONDUCTED DISTURBANCE SUSCEPTIBILITY TEST 11.1 TEST EQUIPMENT

ltem	Instrument	Manufacturer	Model	Serial No.	Last Cal. Date
1	SINGNAL GENERATOR	HP	8657A	3250A05164	11/01/03
2	Power Amplifier	A & R	150A100A	25056	N/A
3	Dual Directional Couplor	A & R	DC-2600	20193	08/04/06
4	VOLTMETER	BOONTON	9200C	361501AA	11/15/03

Note: All equipment upon which need to calibrated are with calibration period of 1 year.

11.2 TEST METHOD

According to EN 55024 : 1998 / CISPR 24 : 1997 IEC 61000-4-6/1996 (EN 61000-4-6/1996).

11.3 BLOCK DIAGRAM OF TEST SETUP

Note: This is a reprehensive setup diagram for Table-top EUT. For Floor-standing EUT, the table will be removed with all others setup condition remain the same.



11.4 SEVERITY LEVELS

Test specification

Required Performance Criteria	:	A
Level	:	3V(rms),1KHz carrier wave with 80/% Amplitude
		modulation

: 0.15-80MHz

Frequency range

According to EN 55024 / 1998 (CISPR 24 / 1997), an additional functional test shall be carried out at the following frequencies: 0.2, 1., 7.1, 13.56, 21.0, 27.12 and 40.68MHz. (+/- 1%)

11.5 OPERATING CONDITIONS OF THE EUT

1. Setup the EUT and Test Equipment as shown on 11.3.

2. Power on the EUT. Acting performance checking program to allow EUT executing its usual operation mode during test.

11.6 TEST PROCEDURE

The EUT and load were placed on a table, which was 0.1 meters high from a Ground reference plane. Prior to the start of the test, a functional test was performed on the EUT to ensure proper operation. The EUT was also monitored during the test for any degradation of performance. Also, prior to the start of the test, clamp injection (RF current probe) calibration measurements were performed as described in IEC 61000-4-6:1996.

For AC Power line test:

The EUT is connected to the power mains through a coupling and decoupling networks for power supply lines. And directly couples the disturbance signal into EUT. Used CDN-M1 for single wire, CDN-M2 for two wires, or CDN-M3 for three wires.

For Signal Lines and Control Lines test:

The disturbance signal is through a coupling and decoupling networks (CDN) or EM-clamp device couples to the signal and control lines of the EUT.

After completion of the test, a functional test was performed on the EUT to ensure proper operation.

11.7 TEST RESULT

Date of Test	October 18, 2004	Temperature	22.7
Test Mode	Mode 1	Humidity	68 %

Frequency Range (MHz)	Inject Line	Field Strength	Inject Method	Required Criteria	Performance Criteria Complied To	Result
0.15~80	AC Line	3V(rms)	CDN-M3	А	А	PASS
0.15~80	LAN	3V(rms)	CDN-M3	А	А	PASS
Additional comprehensive functional test selected frequencies are: 0.2, 1., 7.1, 13.56, 21.0, 27.12 and 40.68MHz. (+/- 1%)						
Frequency Range (MHz)	Inject Line	Field Strength	Inject Method	Required Criteria	Performance Criteria Complied To	Remark
0.2	AC Line	3V(rms)	DIRECT	А	A	PASS
1	AC Line	3V(rms)	DIRECT	A	A	PASS
7.1	AC Line	3V(rms)	DIRECT	A	A	PASS
13.56	AC Line	3V(rms)	DIRECT	A	A	PASS
21	AC Line	3V(rms)	DIRECT	A	A	PASS
27.12	AC Line	3V(rms)	DIRECT	A	A	PASS
40.68	AC Line	3V(rms)	DIRECT	A	А	PASS
0.2	LAN	3V(rms)	CLAMP	A	A	PASS
1	LAN	3V(rms)	CLAMP	A	A	PASS
7.1	LAN	3V(rms)	CLAMP	A	A	PASS
13.56	LAN	3V(rms)	CLAMP	A	А	PASS
21	LAN	3V(rms)	CLAMP	A	A	PASS
27.12	LAN	3V(rms)	CLAMP	A	A	PASS
40.68	LAN	3V(rms)	CLAMP	A	A	PASS

Meet criteria A: Operate as intended during and after the test

Meet criteria B: Operate as intended after the test

Meet criteria C: Loss/Error of function

Additional Information

 \square There was no observable degradation in performance.

EUT stopped operation and <u>could</u> / <u>could not</u> be reset by operator at _____ KV of Line _____.

No false alarms or other malfunctions were observed during or after the test. The acceptance criteria were met, and the EUT passed the test.

12. POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST 12.1 TEST EQUIPMENT

Item	Instrument	Manufacturer	Model	Serial No.	Last Cal. Date
1	MAGNETIC FIELD ANTENNA	HAEFELY	MAG100.1	080015-10	06/23/04

Note: All equipment upon which need to be calibrated are with calibration period of 1 year.

12.2 TEST METHOD

According to EN 55024 : 1998 / CISPR 24 : 1997

IEC 61000-4-8/1993 (EN 61000-4-8/1993).

12.3 BLOCK DIAGRAM OF TEST SETUP

Note: This is a reprehensive setup diagram for Table-top EUT. For Floor-standing EUT, the table will be removed with all others setup condition remain the same.



Shield Room

12.4 SEVERITY LEVELS

Test level for continuous field					Test levels	for short duration: 1to3s
Level	Magnetic Field Strength A/m			Level		Magnetic Field Strength A/m
1		1		1		n.a.
2		3			2	n.a.
3		10			3	n.a.
4	30			4		300
5	100			5		1000
Х	Special				Х	Special
"X" is an open level				"X" is an	open level.	n.a.= not application
Test level (Magnetic Required Perfe		ormance			Test Duration	
Field Strength A/m) Criteria		a				
1 A					Continued Field	

12.5 OPERATING CONDITIONS OF THE EUT

1. Setup the EUT and Test Equipment as shown on 12.3.

2. Power on the EUT. Acting performance checking program to allow EUT executing its usual operation mode during test.

12.6 TEST PROCEDURE

The EUT and its load are placed on a table which is 0.8 meter above a metal ground plane measured at least 1m*1m min. The test magnetic Field shall be applied by the immersion method to the EUT, previously set-up as specified in 12.3. And 90 shall rotate the induction coil° in order to expose the EUT to the test field with different orientation.

12.7 TEST RESULT

Date of Test	October 17, 2004	Temperature	22.8
Test Mode	Mode 1	Humidity	66 %

Magnetic Field Strength A(rms)/m	Induction Coil Orientation	Required Performance Criteria	Performance Criteria Complied To	Test Result
1	Х	А	А	PASS
1	Y	А	А	PASS
1	Z	A	A	PASS

 \boxtimes Meet criteria A: Operate as intended during and after the test

Meet criteria B: Operate as intended after the test

Meet criteria C: Loss/Error of function

☑ Additional Information

There was no observable degradation in performance.

□ EUT stopped operation and <u>could</u> / <u>could not</u> be reset by operator at _____ KV of Line

No false alarms or other malfunctions were observed during or after the test. The acceptance criteria were met, and the EUT passed the test.

13. VOLTAGE DIPS AND SHORT INTERRUPTIONS TEST

13.1 TEST EQUIPMENT

Item	Instrument	Manufacturer	Model	Serial No.	Last Cal. Date
1	DIPS GENERATOR	HAEFFELY	PLING1601	083690-07	09/02/04

Note: All equipment upon which need to be calibrated are with calibration period of 1 year.

13.2 TEST METHOD

According to EN 55024 : 1998 / CISPR 24 : 1997

IEC 61000-4-11/1994+A1/2000 (EN 61000-4-11/1994+A1/2000).

13.3 BLOCK DIAGRAM OF TEST SETUP

Note: This is a reprehensive setup diagram for Table-top EUT.

For Floor-standing EUT, the table will be removed with all others setup condition remain the same.



13.4 SEVERITY LEVELS

Voltage Dips and Interruption Reduction(%)	Test Duration	Required Performance Criteria
>95	10 ms	В
30	500 ms	С
>95	5s	С

13.5 OPERATING CONDITIONS OF THE EUT

- 1. Setup the EUT and Test Equipment as shown on 13.3.
- 2. Power on the EUT. Acting performance checking program to allow EUT executing its usual operation mode during test.

13.6 TEST PROCEDURE

The EUT and its load were placed on a table which was 0.8 meters height.

For AC Power line test:

The EUT was connected to the power mains through a coupling device that directly couples to the Voltage Dips and Interruption Generator.

Voltage dips of >95% for 10ms and 30% for 500ms were applied to the EUT three times with 10 sec intervals between dips. A power interruption of 100% for 5000ms (5 sec) was applied to the EUT three times with 60-second intervals between interruptions.

13.7 TEST RESULT

Date of Test	October 18, 2004	Temperature	22.7
Test Mode	Mode 1	Humidity	66 %

ltem	Phase Angle	Reduction (%)	Test Duration (ms)	Required Criteria	Complied to Criteria	Result
	0			С	С	PASS
	45			С	*	*
) (alta sia	90	> 05		С	*	*
Short Interruptions	135		5000	С	*	*
	🛛 180	>90	5000	С	С	PASS
	225			С	*	*
	270			С	*	*
	315			С	*	*
	0 🛛	>95	10	В	А	PASS
	45			В	*	*
	90			В	*	*
	135			В	*	*
	🛛 180			В	А	PASS
	225			В	*	*
	270			В	*	*
Voltage	315			В	*	*
Dips	0 🛛			С	А	PASS
	45			С	*	*
	90			С	*	*
	135	20	500	С	*	*
	🛛 180	30	500	С	А	PASS
	225			С	*	*
	270			С	*	*
	315			С	*	*

- Meet criteria A: Operate as intended during and after the test
- Meet criteria B: Operate as intended after the test
- Meet criteria C: Loss of function, provided the function is self-recoverable, or can be restored by the operation of the controls
- ☑ Additional Information
 - There was no observable degradation in performance.
 - EUT stopped operation and <u>could</u> / <u>could not</u> be reset by operator at _____ KV of Line _____.
 - No false alarms or other malfunctions were observed during or after the test. The acceptance criteria were met, and the EUT passed the test.

14. PHOTOGRAPHS FOR TEST 14.1 TEST PHOTOGRAPHS FOR CONDUCTION

Mode 1





14.2 TEST PHOTOGRAPHS FOR RADIATED

Mode 1





14.3 TEST PHOTOGRAPHS FOR HARMONIC/FLICKER







14.4 TEST PHOTOGRAPHS FOR ESD

Mode 1



14.5 TEST PHOTOGRAPHS FOR ESD TEST POINTS





14.6 TEST PHOTOGRAPHS FOR RS

Mode 1



14.7 TEST PHOTOGRAPHS FOR EFT

Mode 1



14.8 TEST PHOTOGRAPHS FOR SURGE







14.9 TEST PHOTOGRAPHS FOR CS

Mode 1





14.10 TEST PHOTOGRAPHS FOR MAGNETIC





14.11 TEST PHOTOGRAPHS FOR DIPS

Mode 1





15. PHOTOGRAPHS FOR PRODUCT

- Front View Of 4U Form Factor PXI 18-Slots Chassis (EUT)
 Back View Of 4U Form Factor PXI 18-Slots Chassis (EUT)







3. Inner View Of 4U Form Factor PXI 18-Slots Chassis (EUT)

16. EMI/EMS REDUCTION METHOD DURING COMPLIANCE TESTING

No modification was made during testing.